

## Features

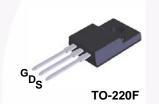
- 700 V @ T<sub>J</sub> = 150 °C
- Typ. R<sub>DS(on)</sub> = 59 mΩ
- Ultra Low Gate Charge (Typ. Q<sub>g</sub> = 78 nC)
- Low Effective Output Capacitance (Typ. C<sub>oss(eff.)</sub> = 715 pF)
- 100% Avalanche Tested
- RoHS Compliant

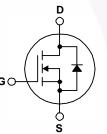
## Applications

- Telecom / Sever Power Supplies
- Industrial Power Supplies
- UPS / Solar



SuperFET<sup>®</sup> III MOSFET is Fairchild Semiconductor's brandnew high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This advanced technology is tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate. Consequently, SuperFET III MOSFET is very suitable for various power system for miniaturization and higher efficiency.





## Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted.

Symbol	Parameter			FCPF067N65S3	Unit	
V <sub>DSS</sub>	Drain to Source Voltage			650	V	
V <sub>GSS</sub>		- DC		±30	V	
	Gate to Source Voltage	- AC	- AC (f>1 Hz)		V	
ID	Drain Current	- Continuous (T <sub>C</sub> = 25 <sup>o</sup> C)		44*	Δ	
		- Continuous ( $T_C = 100^{\circ}C$ )		28*	- A	
I <sub>DM</sub>	Drain Current	- Pulsed	(Note 1)	110*	Α	
E <sub>AS</sub>	Single Pulsed Avalanche Energy (Note 2)		1160	mJ		
I <sub>AR</sub>	Avalanche Current (Note 1)		8.8	Α		
E <sub>AR</sub>	Repetitive Avalanche Energy (Note 1)		0.46	mJ		
dv/dt	MOSFET dv/dt			100	V/ns	
	Peak Diode Recovery dv/dt (Note 3)			20	v/ns	
P <sub>D</sub>	Rower Dissinction	$(T_{C} = 25^{\circ}C)$		46	W	
	Power Dissipation	- Derate Above 25°C		0.37	W/ºC	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range			-55 to +150	°C	
TL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds		300	°C		

\*Drain current limited by maximum junction temperature.

## **Thermal Characteristics**

Symbol	Parameter	FCPF067N65S3	Unit
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case, Max.	2.7	°C/W
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient, Max.	62.5	°C/w

July 2016

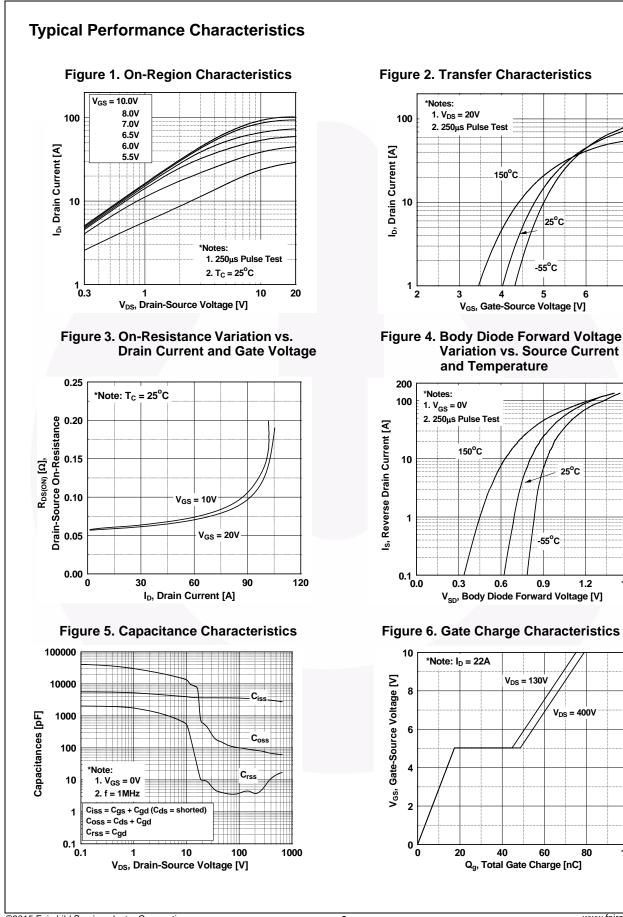
<b>FCPF0</b>
F067N65S3
3   N-0
Channel
el SuperFE
SFET

3 FCPF067N65S3 aracteristics T <sub>C</sub> = 25 <sup>o</sup> Parameter tics to Source Breakdown Voltage kdown Voltage Temperature	V <sub>GS</sub>	Test Condition	N/A	Min.	N/A Typ.	50 Max.	Units
Parameter	V <sub>GS</sub>	Test Condition	IS	Min.	Тур.	Max.	Unit
t <b>ics</b> to Source Breakdown Voltag	10		IS	Min.	Тур.	Max.	Unit
to Source Breakdown Voltag	10	$-0 V = 1 m^{3}$					
	10	$-0 \sqrt{1} - 1 m \sqrt{1}$					
				650	-	-	V
kdown Voltage Temperature	VGS			700	-	-	V
Breakdown Voltage Temperature Coefficient		$I_D = 1$ mA, Referenced to 25°C		-	0.72	-	V/ºC
Gate Voltage Drain Current	$V_{DS} = 650 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		-	-	1	μA	
Zero Gate Voltage Drain Current		$V_{DS} = 520 \text{ V}, \text{ T}_{C} = 125^{\circ}\text{C}$			2.2	-	μΛ
Gate to Body Leakage Current		$V_{GS} = \pm 30 \text{ V}, V_{DS} = 0 \text{ V}$		-	-	±100	nA
ics							
Threshold Voltage	V <sub>G</sub>	$_{\rm S} = V_{\rm DS}, \ {\rm I}_{\rm D} = 4.4 \ {\rm mA}$		2.5	-	4.5	V
Drain to Source On Resista	nce V <sub>G</sub>	<sub>S</sub> = 10 V, I <sub>D</sub> = 22 A		-	59	67	mΩ
ard Transconductance	VDS	<sub>S</sub> = 20 V, I <sub>D</sub> = 22 A		-	29	-	S
cteristics							
Capacitance	Vn	$s = 400V, V_{GS} = 0V,$		-	3090	-	pF
ut Capacitance			-	-	68	-	pF
tive Output Capacitance	V <sub>D</sub>	$_{\rm S} = 0$ V to 400 V, V <sub>GS</sub>	= 0 V	-	715	-	pF
gy Related Output Capacitan	ce V <sub>D</sub>	$_{\rm S} = 0$ V to 400 V, V <sub>GS</sub>	= 0 V	-	104	-	pF
Gate Charge at 10V	Vn			-	78	-	nC
to Source Gate Charge		$V_{GS} = 10 V$	-	18	-	nC	
to Drain "Miller" Charge		(Note 4)		-	30	-	nC
alent Series Resistance	f =	1 MHz		-	0.6	-	Ω
acteristics							
				-	26	-	ns
	VDE	$V_{DD} = 400 \text{ V}, \text{ I}_{D} = 22 \text{ A},$ $V_{GS} = 10 \text{ V}, \text{ R}_{g} = 4.7 \Omega$ (Note 4)			52	-	ns
Off Delay Time	V <sub>G</sub>			-	89	-	ns
Off Fall Time				-	16	-	ns
inde Characteristics	I				-4	1	
	Irce Diode Fc	orward Current				44	А
				-			A
to Source Diode Forward Vo		$_{\rm S} = 0 \text{ V}, \text{ I}_{\rm SD} = 22 \text{ A}$		-	-	1.2	V
		$V_{GS} = 0 V, I_{SD} = 22 A$ $V_{GS} = 0 V, I_{SD} = 22 A,$			105		
rse Recovery Time	Var	h = 0 V lop = 22 A		-	435	-	ns
	tics Threshold Voltage C Drain to Source On Resistan Arard Transconductance Cteristics Capacitance Ut Capacitan	tics Threshold Voltage Threshold Voltage Transconductance VG: Ceristics Capacitance UD: Capaci	ticsThreshold Voltage $V_{GS} = V_{DS}$ , $I_D = 4.4$ mAc Drain to Source On Resistance $V_{GS} = 10$ V, $I_D = 22$ Avard Transconductance $V_{DS} = 20$ V, $I_D = 22$ Acteristics $V_{DS} = 20$ V, $I_D = 22$ Acteristics $V_{DS} = 400$ V, $V_{GS} = 0$ V,ctapacitance $V_{DS} = 400$ V, $V_{GS} = 0$ V,ut Capacitance $V_{DS} = 0$ V to $400$ V, $V_{GS}$ gy Related Output Capacitance $V_{DS} = 0$ V to $400$ V, $V_{GS}$ gate Charge at 10V $V_{DS} = 400$ V, $I_D = 22$ A,to Source Gate Charge $V_{GS} = 10$ Vvalent Series Resistance $f = 1$ MHzacteristics $V_{OD} = 400$ V, $I_D = 22$ A,On Delay Time $V_{OD} = 400$ V, $I_D = 22$ A,Off Delay Time $V_{GS} = 10$ V, $R_g = 4.7$ $\Omega$ Off Fall Time $V_{OD} = 400$ V, $R_g = 4.7$ $\Omega$ iode Characteristics $V_{OT} = 10$ V, $R_g = 4.7$ $\Omega$ mum Continuous Drain to Source Diode Forward Currentmum Pulsed Drain to Source Diode Forward Current	ticsa Threshold Voltage $V_{GS} = V_{DS}$ , $I_D = 4.4$ mAc Drain to Source On Resistance $V_{GS} = 10 \text{ V}$ , $I_D = 22 \text{ A}$ vard Transconductance $V_{DS} = 20 \text{ V}$ , $I_D = 22 \text{ A}$ cteristicscapacitance $V_{DS} = 400 \text{ V}$ , $V_{GS} = 0 \text{ V}$ ,ut Capacitance $f = 1 \text{ MHz}$ trive Output Capacitance $V_{DS} = 0 \text{ V to } 400 \text{ V}$ , $V_{GS} = 0 \text{ V}$ gy Related Output Capacitance $V_{DS} = 0 \text{ V to } 400 \text{ V}$ , $V_{GS} = 0 \text{ V}$ gy Related Output Capacitance $V_{DS} = 0 \text{ V to } 400 \text{ V}$ , $V_{GS} = 0 \text{ V}$ got act Charge at $10 \text{ V}$ $V_{DS} = 400 \text{ V}$ , $I_D = 22 \text{ A}$ ,to Source Gate Charge $V_{GS} = 10 \text{ V}$ to Drain "Miller" Charge $V_{CS} = 10 \text{ V}$ on Delay Time $V_{DD} = 400 \text{ V}$ , $I_D = 22 \text{ A}$ ,Off Delay Time $V_{GS} = 10 \text{ V}$ , $V_{GS} = 10 \text{ V}$ , $V_{GS} = 10 \text{ V}$ , $R_g = 4.7 \Omega$ iode Characteristics $(Note 4)$ mum Continuous Drain to Source Diode Forward Currentmum Pulsed Drain to Source Diode Forward Current	ticsThreshold Voltage $V_{GS} = V_{DS}$ , $I_D = 4.4 mA$ 2.5c Drain to Source On Resistance $V_{GS} = 10 V$ , $I_D = 22 A$ -vard Transconductance $V_{DS} = 20 V$ , $I_D = 22 A$ -cteristicscteristics-ctapacitance $V_{DS} = 400V$ , $V_{GS} = 0 V$ ,ut Capacitance $V_{DS} = 0 V to 400 V$ , $V_{GS} = 0 V$ -ut Capacitance $V_{DS} = 0 V to 400 V$ , $V_{GS} = 0 V$ -gy Related Output Capacitance $V_{DS} = 0 V to 400 V$ , $V_{GS} = 0 V$ -gy Related Output Capacitance $V_{DS} = 400 V$ , $I_D = 22 A$ ,-to Source Gate Charge $V_{GS} = 10 V$ -to Drain "Miller" Charge(Note 4)-valent Series Resistancef = 1 MHz-On Delay TimeOn Delay Time $V_{DD} = 400 V$ , $I_D = 22 A$ ,-Off Delay Time $V_{CS} = 10 V$ , $R_g = 4.7 \Omega$ -off Fall Time(Note 4)-iode Characteristicsmum Continuous Drain to Source Diode Forward Current-mum Pulsed Drain to Source Diode Forward Current-	ticsa Threshold Voltage $V_{GS} = V_{DS}$ , $I_D = 4.4 \text{ mA}$ 2.5-c Drain to Source On Resistance $V_{GS} = 10 \text{ V}$ , $I_D = 22 \text{ A}$ -59rard Transconductance $V_{DS} = 20 \text{ V}$ , $I_D = 22 \text{ A}$ -29cteristicscteristicscapacitance $V_{DS} = 400 \text{ V}, V_{GS} = 0 \text{ V}, -3090ut capacitanceV_{DS} = 400 \text{ V}, V_{GS} = 0 \text{ V}, -3090ut capacitanceV_{DS} = 400 \text{ V}, V_{GS} = 0 \text{ V}, -715gy Related Output CapacitanceV_{DS} = 0 \text{ V} to 400 V, V_{GS} = 0 \text{ V}, -104Gate Charge at 10VV_{DS} = 400 \text{ V}, I_D = 22 \text{ A}, -78Vosume of the transformation of transformation of transformation of the transform$	tics         a Threshold Voltage $V_{GS} = V_{DS}$ , $I_D = 4.4 \text{ mA}$ 2.5       -       4.5         c Drain to Source On Resistance $V_{GS} = 10 \text{ V}$ , $I_D = 22 \text{ A}$ -       59       67         vard Transconductance $V_{DS} = 20 \text{ V}$ , $I_D = 22 \text{ A}$ -       29       -         cteristics       -       29       -       29       -         cteristics       -       68       -       29       -         ctapacitance $V_{DS} = 4000 \text{ V}, V_{GS} = 0 \text{ V},$ -       3090       -         ut Capacitance $V_{DS} = 4000 \text{ V}, V_{GS} = 0 \text{ V},$ -       68       -         gy Related Output Capacitance $V_{DS} = 0 \text{ V to 400 V}, V_{GS} = 0 \text{ V},$ -       104       -         Gate Charge at 10V $V_{DS} = 400 \text{ V}, I_D = 22 \text{ A},$ -       78       -         to Drain "Miller" Charge $V_{GS} = 10 \text{ V}$ -       18       -         valent Series Resistance       f = 1 MHz       -       0.6       -         acteristics       -       18       -       -       26       -         On Delay Time       - $V_{OS} = 10 \text{ V}, R_g = 4.7 \Omega$ -       52

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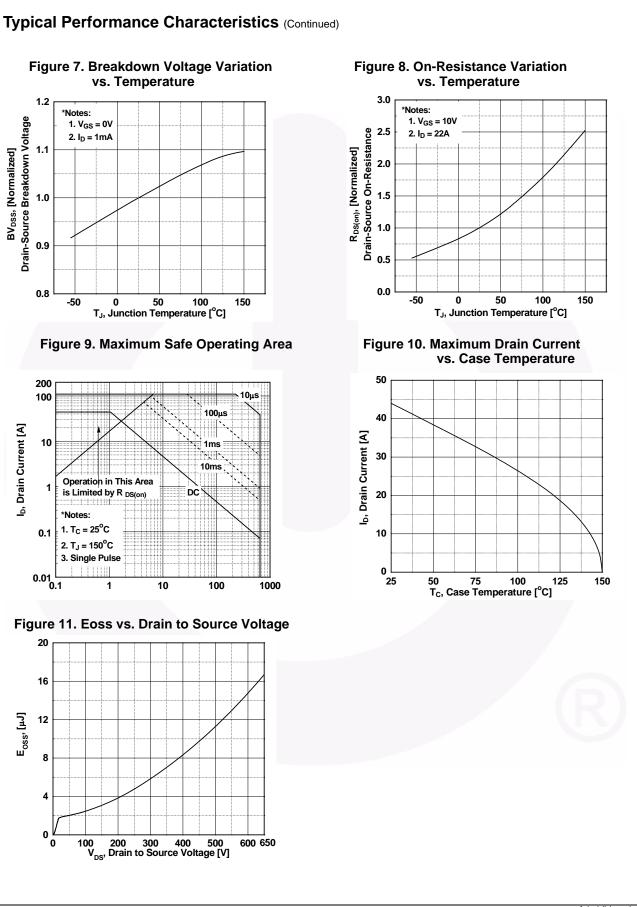
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1.2

1.1

1.0

0.9

0.8

200 100

10

1

0.1

0.01 └─ 0.1

20

16

8

4

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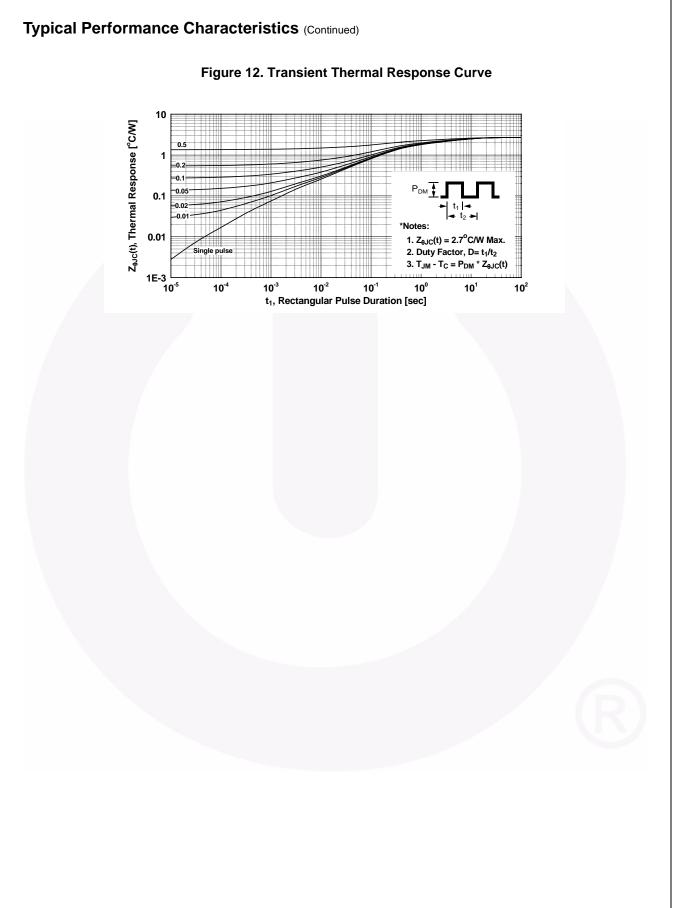
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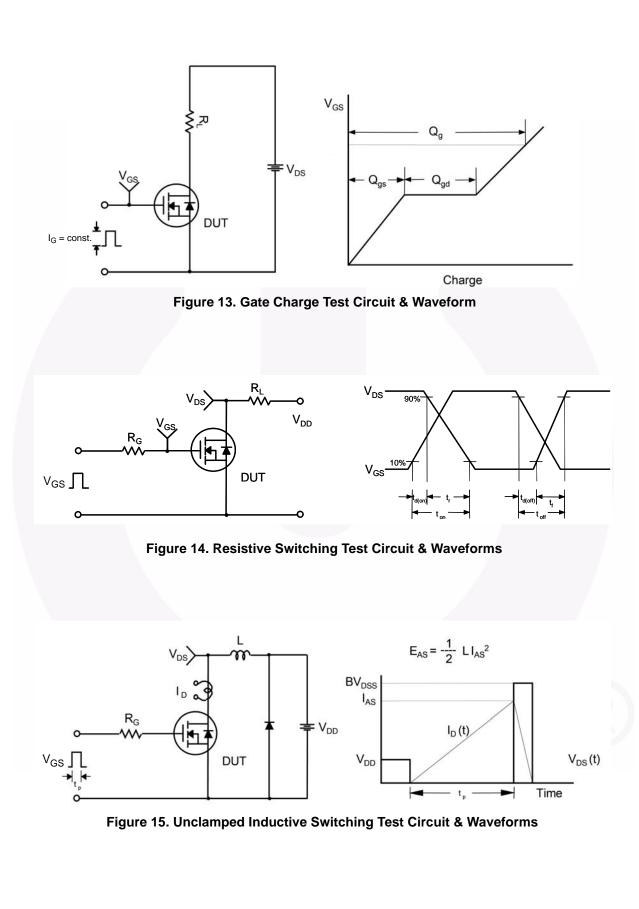
Е<sub>oss</sub>, [µJ] 12

l<sub>b</sub>, Drain Current [A]

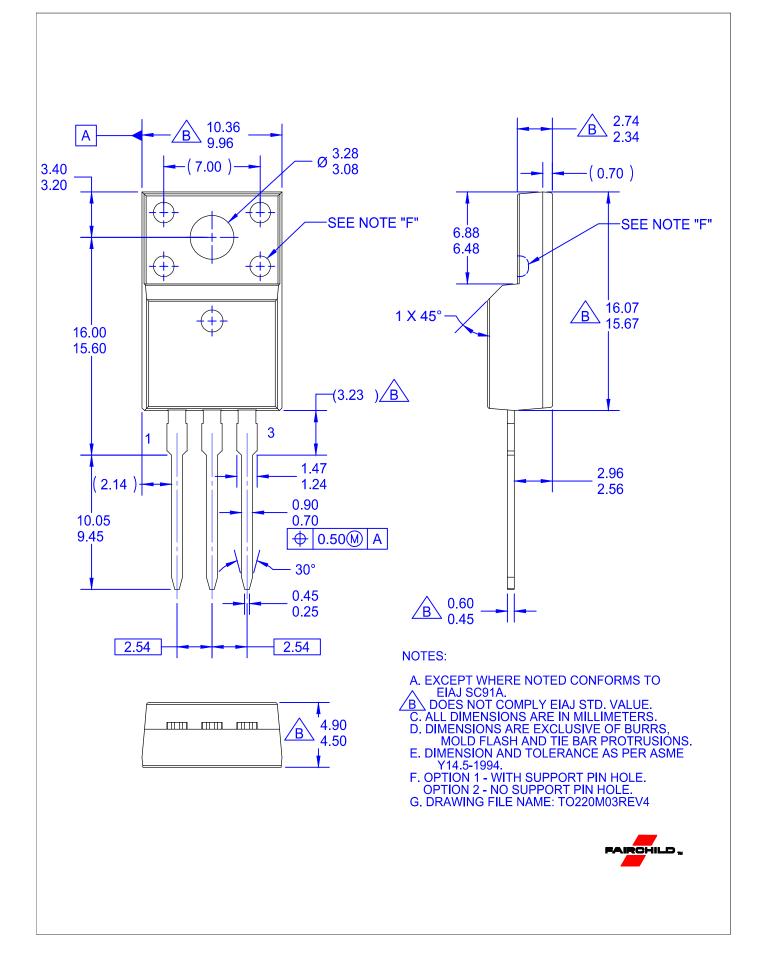
Drain-Source Breakdown Voltage

BV<sub>DSS</sub>, [Normalized]





DUT + ۱<sub>sD</sub> م 0 L Driver R<sub>G</sub>, Same Type as DUT  $V_{DD}$ ∏∏ V<sub>GS</sub> • dv/dt controlled by  $R_{G}$  $\bullet \ {\rm I}_{\rm SD}$  controlled by pulse period Î Gate Pulse Width  $V_{GS}$ D = Gate Pulse Period 10V (Driver) T IFM , Body Diode Forward Current  $I_{SD}$ di/dt (DUT)  $I_{RM}$ Body Diode Reverse Current  $V_{\text{DS}}$ (DUT) Body Diode Recovery dv/dt V<sub>DD</sub> V<sub>SD</sub> Body Diode Forward Voltage Drop Figure 16. Peak Diode Recovery dv/dt Test Circuit & Waveforms





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